(19) World Intellectual Property Organization International Bureau





(43) International Publication Date 3 February 2005 (03.02.2005)

PCT

(10) International Publication Number WO 2005/010617 A2

(51) International Patent Classification⁷: G02B 27/00

G03F 7/20,

(21) International Application Number:

PCT/IB2004/051250

(22) International Filing Date:

19 July 2004 (19.07.2004)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data: 03102333.6

29 July 2003 (29.07.2003) E

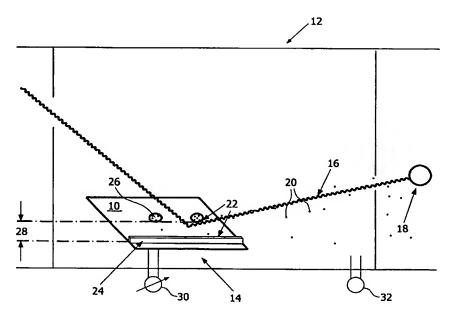
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- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH,

[Continued on next page]

(54) Title: METHOD OF CLEANING AT LEAST ONE SURFACE OF AN OPTICAL DEVICE DISPOSED IN A VACUUM CHAMBER



(57) Abstract: A method of cleaning at least one surface of an optical device disposed in a vacuum chamber, which is at least partially contaminated by atoms and/or ions of metalloid and/or metal introduced by a radiation source generating, in particular, extreme ultraviolet radiation and/or 10 soft X-rays is described. In order to achieve a longer service life for the optical device (14), the method is designed such that a temperature prevailing on the surface (10) and/or a pressure in the vacuum chamber (12) is adjusted in such a way that the atoms and/or ions (20) hitting the surface (10) can move upon it.

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Published:

 without international search report and to be republished upon receipt of that report

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